Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YOSHINO ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0077896	06-2002	Liu et al.	705/14
*	В	US-2003/0212745	11-2003	Caughey, David A.	709/206
*	С	US-6,473,629	10-2002	Chang, Yun-Seok	455/566
	D	US-			
	Ε.	US-		·	
	F	US-		·	
	G	US-			
	н	US-			
	1	US-		·	
	J	US-			
	К	US-			0
	L	US-			
-	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0	·				
	Р					
	Q					
	R					
	s					
	1					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U						
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	x						

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